



A DM Interpretation of Multiple Direct Detection Excesses Gordan Krnjaic

+ Noah Kurinsky, Dan Baxter, Yonatan Kahn arXiv:2002.06937 Phys. Rev. D 102, 015017

Lund University Seminar Sep 24, 2020

Open Questions in Fundamental Physics



Also Quantum Gravity

Remarkable Evidence for Dark Matter

101

SEBN f.c.

10

 10^{2}

C/H

 \mathbf{H}_{1} :E^C

 Ξ/H

 n 3:/H

 2 Li/H

 3 $\sqrt{11}$



Multiple independent, consistent observations over **nearly** all of spacetime (!)

Holy Grail: extend our knowledge down to laboratory scales

Nuclear Recoil (NR) Direct Detection



Insensitive to DM masses below < GeV

Nuclear Recoil Direct Detection



*doesn't measure integrated rate

Undagoitia, Rauch 1509.08767

Nuclear Recoil Direct Detection



Current status: null results for weak scale DM What about lighter DM (< GeV)?

Schaumann 1903.02026

Overview

1) There are many weird direct-detection excesses

2) There is a candidate process to characterize these events

3) Currently no known plausible SM explanation

4) This process may originate from DM interactions

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Low Threshold Revolution

Lighter DD targets probe sub-GeV DM





Scatter electrons, not nuclei

$$|\vec{q}| \sim m_e \alpha \quad , \quad E_e = \frac{|\vec{q}|^2}{2m_e}$$

Measure *ionization* 1-electron sensitivity

See Rouven Essig's slides

SENSEI (Charge Readout)

Silicon semiconductor



100 m detector depth100 K temperature

0.2 e resolution0.2 gram day exposure

SENSEI Collab. PRL 122, 161801 (2019)

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100 m detector depth100 K temperature

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Excess Rate = 6 - 400 Hz/kg

SENSEI Collab. PRL 122, 161801 (2019)

SENSEI Collaboration 2004.11378

SENSEI (Charge Readout)

Silicon semiconductor



100 m detector depth0.2 e resolution100 K temperature0.2 gram day exposureApril 2020 Update: Excess* Rate~ (0.01-1) Hz/kg

SENSEI Collab. PRL 122, 161801 (2019)

SENSEI Collaboration 2004.11378

CDMS-HVeV (Charge Readout)



Charge (e/h pairs)

1 m detector depth
 10 mK temperature

0.1 e resolution0.5 gram day exposure

CDMS-HVeV 1804.10697

CDMS-HVeV (Charge Readout)



EDELWEISS (Charge Readout)

Germanium semiconductor



2 km detector depth 10 mK temperature

1.6 e resolution80 gram day exposure

EDELWEISS Collaboration 2003.01046

EDELWEISS (Charge Readout)





2 km detector depth 10 mK temperature

1.6 e resolution80 gram day exposure

Excess Rate = 20 - 100 Hz/kg (without/with first bin)

EDELWEISS Collaboration 2003.01046

DAMIC (Charge Readout)



DAMIC Collaboration PRL 1907.12628

2 km detector depth 100 K temperature

1.2 e resolution200 gram day exposure

They report a low "dark count" rate $\sim 10^{-3} \,\mathrm{Hz/kg}$

DAMIC (Charge Readout)



DAMIC Collaboration PRL 1907.12628

1) Uses a different ionization model from others

2) Reports "dark counts" based on likelihood analysis Prior: all events treated as "dark count" BG Could be misattributing would-be signal

Our interpretation: conservative upper bound ~ 7 Hz/kg

Semiconductor Summary

Readout Type	Target	Resolution	Exposure	Threshold	Excess Rate (Hz/kg)	Depth	Reference
Charge (E_e)	Ge	$1.6 e^{-}$	$80 \text{ g} \cdot \text{d}$	$0.5 \text{ eVee } (\sim 1e^{-})^{\mathrm{a}}$	[20, 100]	7 km	EDELWEISS [6]
	Si	$\sim 0.2 e^{-1}$	$0.18 \mathrm{g} \cdot \mathrm{d}$	$1.2 \text{ eVee} (< 1 e^{-})$	[6, 400]	100 m	SENSEI [4]
	Si	$0.1 \ e^-$	$0.5 \mathrm{g} \cdot \mathrm{d}$	$1.2 \text{ eVee} (< 1 e^{-})$	[10, 2000]	~1 m	CDMS HVeV [3]
	Si	$1.6 e^{-}$	200 g · d	$1.2 \text{ eVee} (\sim 1e^{-})$	$[1 \times 10^{-3}, 7]$	$2 \mathrm{km}$	DAMIC [7]

Intriguing coincidence of rates

Different Depths
Different Shielding
Different Exposures
Different Composition
Different Temperatures
Different Pressures

Unlike nuclear recoil: these are integrated total rates! Semiconductors have tiny thresholds

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	Ge	18 eV	$200 \mathrm{g} \cdot \mathrm{d}$	60 eV	> 2	~1 m	EDELWEISS [1]
Energy (E_{det})	CaWO ₄	4.6 eV	$3600 \mathrm{g} \cdot \mathrm{d}$	$30 \mathrm{eV}$	$> 3 \times 10^{-3}$	4 km	CRESST-III [2]
	Al_2O_3	$3.8 \mathrm{eV}$	$0.046 \text{ g} \cdot \text{d}$	20 eV	> 30	$\sim 1 \text{ m}$	$\nu \text{CLEUS} [8]$
Photo e^-	Xe	6.7 PE (~ $0.25 e^{-}$)	$15 \mathrm{kg} \cdot \mathrm{d}$	$12.1 \text{ eVee} (\sim 14 \text{ PE})$	$[0.5, 3] \times 10^{-4}$	4 km	XENON10 [5, 9]
	Xe	6.2 PE (~ $0.31 e^{-}$)	$30 \text{ kg} \cdot \text{yr}$	$\sim 70 \text{ eVee} (\sim 80 \text{ PE})$	$> 2.2 \times 10^{-5}$	4 km	XENON100 [5]
	Xe	< 10 PE	$60 \text{ kg} \cdot \text{yr}$	$\sim 140 \text{ eVee} (\sim 90 \text{ PE})$	$> 1.7 \times 10^{-6}$	4 km	XENON1T [10]
	Ar	$\sim 15 \text{ PE} (\sim 0.5 e^{-})$	6780 kg $\cdot\mathrm{d}$	50 eVee	$> 6 \times 10^{-4}$	4 km	Darkside50 [11]

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-EDELWEISS has excess in both *Ee* and *Edet* runs

Excesses vs. Depth



Includes new SENSEI 2020 result 2004.11378 (plot from FNAL wine/cheese seminar)

Overview

1) There are many weird direct-detection excesses

2) There is a candidate process to characterize these events

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Why's Nobody Reporting a Signal?

EDELWEISS Case Study

EDELWEISS has data in both ER and NR

Both ER and NR runs observe excesses

Interpreting these as the *same process* implies a charge model

$$E_e = E_{det} \left[y(E_{det}) + \frac{\epsilon_{eh}}{e \cdot V_{det}} \right]$$

Can we find a consistent description?

J. Gascon

http://vietnam.in2p3.fr/2020/tmex/transparencies/2_tuesday/2_afternoon/5_gascon.pdf

Assume EDELWEISS runs arise from DM-electron scattering



ER only prediction can't fit under black curve: BAD FIT

$$E_e = E_{det} \left[y(E_{det}) + \frac{\epsilon_{eh}}{e \cdot V_{det}} \right]$$

Nuclear Recoil Interpretation?

Assume EDELWEISS runs arise from DM-nucleon scattering



NR-only prediction can't fit under black curve: BAD FIT

$$E_e = E_{det} \left[y(E_{det}) + \frac{\epsilon_{eh}}{e \cdot V_{det}} \right]$$

Another Possibility?

Assume the excess is due to some inelastic* process



Key feature: constant piece independent of *Edet*

*Not to be confused with inelastic DM!

Consider Semiconductor Plasmons

Long wavelength charge oscillation between electrons/ions >> lattice spacing

phonons (momentum)



Plasmon excitation energy

$$E_p \simeq \sqrt{\frac{4\pi\alpha n_e}{m_e}}$$

Low-P standing wave decays to e/h pairs or phonons Breaks usual charge heat yield relationship



MK Kundmann PhD Thesis 1988

"Inelastic" Yield Model



Key point: model can now fit under black curve General result not limited to plasmons Overview

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Solar *pp* Neutrinos?

Most abundant terrestrial neutrino flux



Photons/Electrons?

Photons: Transversely polarized & can't source plasmons which are longitudinally polarized

Electrons: Mean free path ~ nm Would multiple scatter and create many plasmons Not observed: need single energy deposit < 100 eV

Muons?



Muon flux has known scaling with depth

Neutrons?

Possible in principle

Neutron could scatter nucleus, excite secondary plasmon Possible calibration strategy

Baxter, Kahn, Kurinsky, GK [in preparation]

Hard to explain all excesses this way

Different Depths Different Shielding Different Exposures Different Composition

Why is the neutron flux independent of these factors?

Overview

1) There are many weird direct-detection excesses

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b) Secondary Plasmon Excitation

Extend EELS analogy: "millicharged" DM



DM excites plasmon directly through its own Coulomb field Longer mean free path, << 1 interaction per crossing

Can use measured EELS plasmon excitation prob.

$$\begin{aligned} \frac{dP}{dtd\omega} &= \frac{e^2}{4\pi^3} \int d^3 \mathbf{q} \, \frac{1}{q^2} \mathrm{Im} \left\{ \frac{-1}{\epsilon(\omega, \mathbf{q})} \right\} \\ & \times \delta \left(\omega - \mathbf{q} \cdot \mathbf{v} + \frac{q^2}{2m_{\chi}} \right) \end{aligned}$$

Need forward scatter ($\cos > 0$) for low q-transfer

$$q = \frac{E}{v\cos\theta} + \frac{q^2}{2m_{\chi}v\cos\theta} \quad \longrightarrow \quad v \ge E_p/q_p = 6.5 \times 10^{-3} \left(\frac{E_p}{16 \text{ eV}}\right)$$

Minimum (high!) velocity for direct plasmon excitation

MK Kundmann PhD Thesis 1988

Approximate shape with Lorentzian fit (Frolisch model)



Completely calculable (rescale EELS rate by charge)

$$\frac{dR}{dE} = \frac{f\rho_{\chi}}{m_{\chi}\rho_T} \frac{2\kappa^2 \alpha_D}{\pi} S(E) \int_0^{q_c} \frac{dq}{q} \eta(v_{\min}(q, E))$$

MK Kundmann PhD Thesis 1988

Need fraction *f* of DM population with boosted velocity



Shaded region ~ 10 Hz/kg in Ge

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Step 1: DM induces a feeble nuclear recoil Contact interaction, conventional DM velocity



+ Plasmon & Phonons

Step 2: Nuclear recoil triggers plasmon excitation

See also Lin & Kozaczuk 2003.12077 for plasmon + single phonon study

Unlike millicharged scenario:

1) Use 100% of the DM population

2) Use the usual DM velocity distribution

3) Can't calculate secondary plasmon excitation rate

$$R \sim N_T \mathcal{P} \frac{\rho_{\chi}}{m_{\chi}} \sigma_n v_{z}$$

Parametrize our ignorance



Naive limits for equal electron/proton couplings Translated from DM-e scattering limits



Naive limits don't apply Red = favored region



$$\mathcal{L} \supset -\frac{m_{A'}^2}{2} A'_{\mu} A'^{\mu} + A'_{\mu} (\kappa e J^{\mu}_{\rm EM} + g_D J^{\mu}_D),$$

Dark photon mediator Contact interaction

- Future results should continue to see ~ Hz/kg excesses
 Despite improved shielding + BG rejection
- 2) Annual modulation (but weird!) Large rates, should already be possible No shift in signal shape, only normalization Anisotropic crystals (daily modulation?)
- **3) Other materials should see this** Xenon crystal should see increased rate over liquid Xe, etc.
- **4)** Neutron Scattering in Ge should see plasmon Measures secondary excitation probability

Conclusion

1) There are many sub-GeV direct-detection excesses

2) There is a candidate process to explain these results

3) Currently no known plausible SM explanation

4) This process may originate from DM interactions

-direct plasmon excitation (fast millicharge DM fraction)-secondary plasmon excitation (normal DM setup)

Thanks!

Backup

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> Collar, Baxter, Kahn, Kavner, GK [in preparation] Baxter, Kahn, Kurinsky, GK [in preparation]

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Why is the neutron flux independent of these factors?

Q: Can the "Migdal effect" realize this?



Same inelastic kinematics, vastly different dynamics!

Ibe, Nakano, Shoji, Suzuki 1707.07258

Baxter, Kahn, GK 1908.00012

Q: Can the "Migdal effect" realize this?

A: PROBABLY NOT

Migdal rates from Ibe et. al. too low, however:

Calculations assume single-atom systems

Also assume Hydrogenic wave functions

No treatment of multi-body physics (phonons etc)

See recent progress: Essig, Pradler, Sholapurkar, Yu 1908.10881

Ibe, Nakano, Shoji, Suzuki 1707.07258

Baxter, Kahn, GK 1908.00012